

Session Program

19-23 May 2014

Front End Electronics (FEE 2014)

Advanced CMOS and Extreme Environments Session II

Argonne National Laboratory, Energy Sciences Building
Argonne National Laboratory 9700 S. Cass Avenue Lemont, IL 60439

Friday 23 May

10:15

Advanced CMOS and Extreme Environments Session II

Session |

Location: Argonne National Laboratory, Energy Sciences Building, Argonne National Laboratory 9700 S. Cass Avenue
Lemont, IL 60439 |

Convener: Gary Varner

10:15-10:40

Radiation Damage Tests at 1 Grad Dose on 65 nm CMOS Transistors

Speaker

Marlon Benoit Barbero

10:40-11:05

LArASIC4 Noise Results in Liquid Argon Long Drift Tests

Speaker

Dr Igor Kreslo

11:05-11:30

CMOS Lifetime at 300K and at 77K

Speaker

Shaorui Li

11:30